

Search Notes

Application/Control No.

10/507,192

Examiner

Hieu P. Nguyen

Applicant(s)/Patent under
Reexamination

KWONG, KAM CHOON

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	51	1/10/2006	HN
330	254	1/10/2006	HN
330	282	1/10/2006	HN
330	285	10/10/2006	HN
330	86	1/11/2006	HN
330	296	1/10/2006	HN
330	110	1/11/2006	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
MOTTOLA STEVEN J	1/17/2006	HN